

# INFORMATION DISCLOSURE CITATION

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 Applicant Hiroshi NOMURA and Kenji KONOMI  
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## U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Dat if Appropriate
DBE	4,908,656	3/13/90	Suwa et al.			
DBE	5,300,786	4/5/94	Brunner et al.			
DBE	5,948,571	9/7/99	Mih et al.			
DBE	6,011,611	1/4/00	Nomura et al.			
DBE	6,114,096	9/5/00	Mih et al.			
DBE	6,130,747	10/10/00	Nomura et al			

## FOREIGN PATENT DOCUMENTS


Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or N

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

DBE	T.A. Brunner et al., " QUANTITATIVE STEPPER METROLOGY USING THE FOCUS MONITOR TEST MASK", Optical/Laser Microlithography VII, Timothy A. Brunner ed., Proc. SPIE, Vol. 2197, pp 541-549 (1994).
DBE	J.P. Kirk et al., "APPLICATION OF BLAZED GRATINGS FOR DETERMINATION OF EQUIVALENT PRIMARY AZIMUTHAL ABERRATIONS", Optical Microlithography XII, Luc Van den Hove ed., Proc. SPIE. Vol. 3679, 70-76 (1999)

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INFORMATION DISCLOSURE CITATION 	Atty. Docket No.	Serial No.
	4329,2620	09/923,443
	Applicant	
	Nomura et al.	
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	August 8, 2001	Unknown

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*Examiner Initial	Document Number	Date	Country	Class	Sub- Class	Translation	
						Yes	No
	11-237310	8/31/99	Japan				XX

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

DBE	Kirk, "Astigmatism and field curvature from pin-bars," March 6-8, 1991, SPIE, 1463:282-291

Examiner <i>P. Blum</i>	Date Considered <i>6/28/03</i>
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- \* Examiner: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.